<u>TOSHIBA</u>

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK2993

Chopper Regulator, DC–DC Converter and Motor Drive Applications

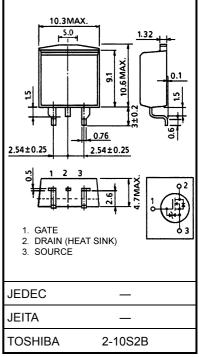
- Low drain-source ON resistance $: R_{DS} (ON) = 82 m\Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 20 \text{ S (typ.)}$
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 250 \ V)$
- Enhancement-mode $: V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	250	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	250	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	۱ _D	20	А	
	Pulse (Note 1)	I _{DP}	60	A	
Drain power dissipatio	n (Tc = 25°C)	PD	100	W	
Single pulse avalanche energy (Note 2)		E _{AS}	423	mJ	
Avalanche current		I _{AR}	20	А	
Repetitive avalanche energy (Note 3)		E _{AR}	10	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Unit: mm 10.3MAX 5.0 1.32 10.6 MAX 2.5 MAX 1.6 MA) 0.76 2.54±0.25 2.54±0.25 ZMA 2 3 GATE 2. DRAIN (HEAT SINK) 3. SOURCE JEDEC JEITA TOSHIBA 2-10S1B

Weight: 1.5 g (typ.)



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Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	1.25	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	83.3	°C / W

- Note 1: Please use devices on condition that the channel temperature is below 150°C.
- Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 1.79 mH, I_{AR} = 20 A, R_G = 25 Ω
- Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device. Please handle with caution.

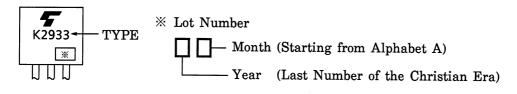
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	urrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V	_	_	100	μA
Drain-source br	reakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	250	_		V
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 10 A	_	82	105	mΩ
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 10 A	10	20	_	S
Input capacitance	ce	C _{iss}		_	4000	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	300	_	pF
Output capacitance		Coss			1000	_	
Switching time	Rise time	t _r	$V_{GS} \stackrel{10V}{}_{0V} \int_{\mathcal{C}} \stackrel{I_{D}=10A}{}_{\mathcal{C}} V_{OUT}$	_	15	_	
	Turn-on time	t _{on}		_	35	_	
	Fall time	t _f		_	30	_	ns
	Turn-off time	t _{off}	V_{DD} ≒130V Duty ≤1%, t _w =10µs	_	180	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	100	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 200 V, V _{GS} = 10 V, I _D = 20 A		70	—	nC
Gate-drain ("miller") Charge		Q _{gd}			30		

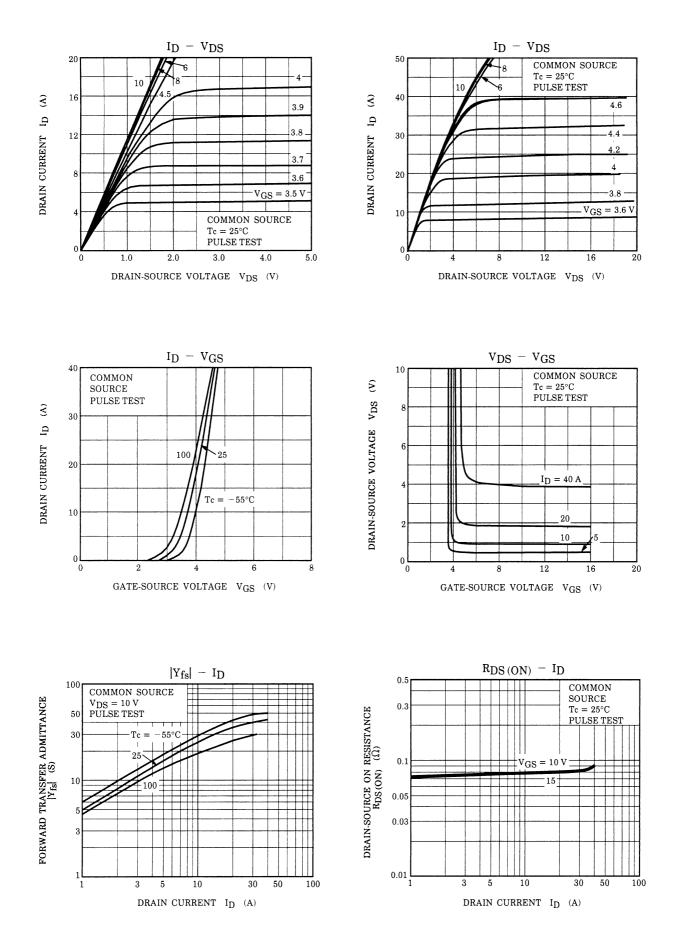
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	20	A
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	60	A
Forward voltage (diode)	V _{DSF}	I _{DR} = 20 A, V _{GS} = 0 V	_	_	-2.0	V
Reverse recovery time	t _{rr}	I _{DR} = 20 A, V _{GS} = 0 V dI _{DR} / dt = 100 A / μs		300	—	ns
Reverse recovery charge	Qrr	dI _{DR} / dt = 100 A / μs	_	3.3	—	μC

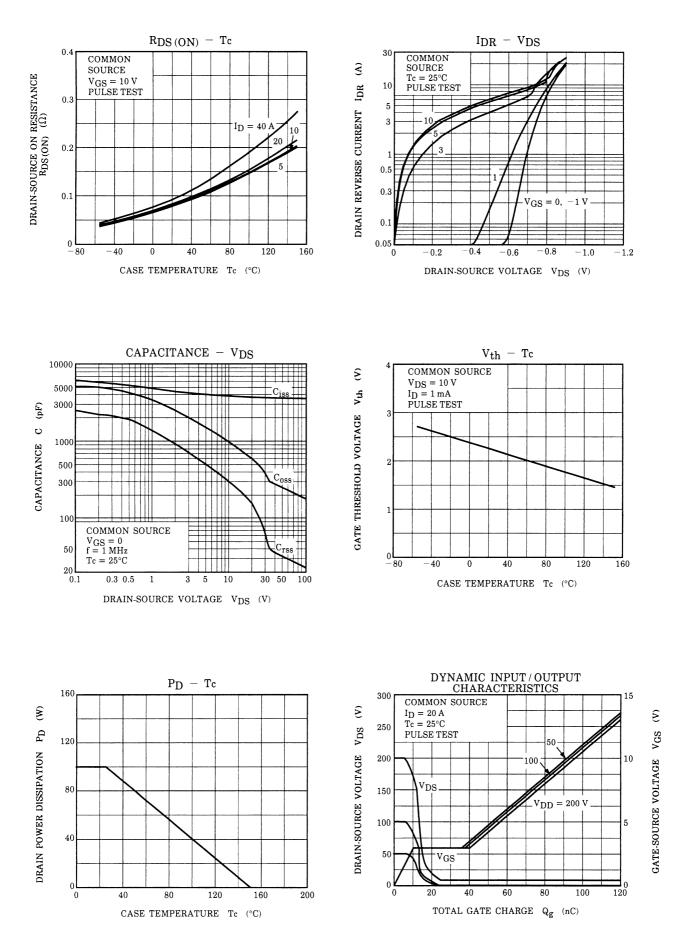
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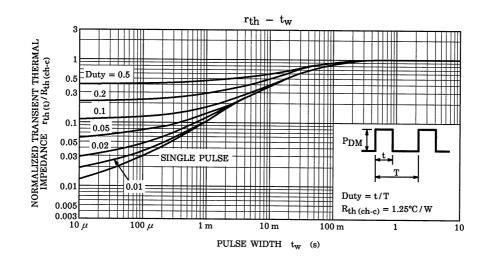


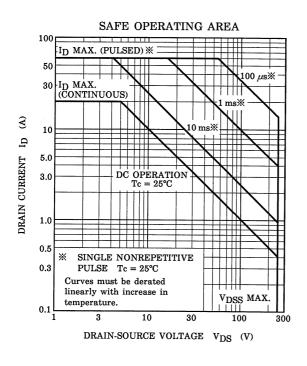
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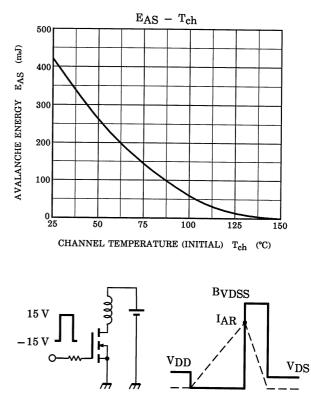


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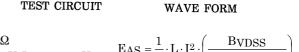












 $RG = 25 \Omega$ $E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$ VDD = 90 V, L = 1.79 mH

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